GC2M023170K

N-Channel SiC Power MOSFET

G2 MOSFET Technology

V_{DS} = 1700 V
$R_{DS(on)}$ = 20 mΩ
$I_{D@25°C}$ = 119 A

Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitance
- Easy to Parallel and Simple to Drive

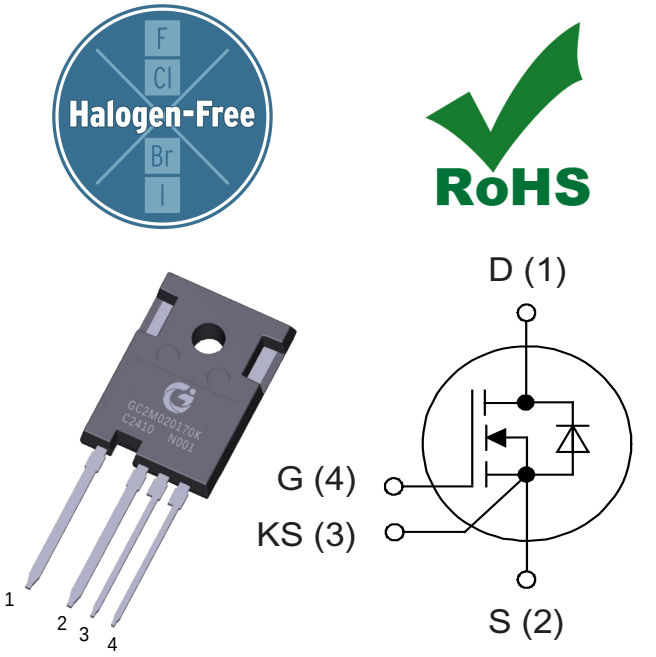
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Solid-state Circuit Breaker
- Industrial Inverters/Converters
- Uninterruptible Power Supply
- EV motor drive

Package



Part Number	Package
GC2M023170K	TO-247-4

Maximum Ratings (T_C=25℃ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain-Source Voltage	1700	V	V_{GS}=0V, I_D=100μA	
V_{GSmax}	Gate-Source Voltage	-8/+22	V	Absolute maximum values	
V_{GSop}	Gate-Source Voltage	-4/+18	V	Recommended operational values	
I_D	Continuous Drain Current	119	A	V_{GS}=18V, T_c=25℃	Fig. 19
		85		V_{GS}=18V, T_c=100℃	
$I_{D(pulse)}$	Pulsed Drain Current	250	A	Pulse width t_p limited by T_{Jmax}	
P_D	Power Dissipation	714	W	T_c=25℃, T_J=175℃	Fig. 20
T_J, T_{STG}	Operating Junction and Storage Temperature	-55 to +175	℃		
T_L	Solder Temperature, 1.6mm from case for 10s	260	℃		
M_d	Mounting Torque, (M3 or 6-32 screw)	1 8.8	Nm lbf-in		

Electrical Characteristics (T_C=25℃ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1700	/	/	V	V_{GS}=0V, I_D=100μA	
$V_{GS(th)}$	Gate Threshold Voltage	1.9	2.6	4.0	V	V_{DS}=V_{GS}, I_D=25.4mA	Fig. 11
		/	1.8	/		V_{DS}=V_{GS}, I_D=25.4mA, T_J=175℃	
I_{DSS}	Zero Gate Voltage Drain Current	/	1	100	μA	V_{DS}=1700V, V_{GS}=0V	
I_{GSS+}	Gate-Source Leakage Current	/	10	250	nA	V_{DS}=0V, V_{GS}=22V	
I_{GSS-}	Gate-Source Leakage Current	/	10	250	nA	V_{DS}=0V, V_{GS}=-8V	
$R_{DS(on)}$	Drain-Source On-State Resistance	/	20	24	mΩ	V_{GS}=18V, I_D=75A	Fig. 4,5,6
		/	40.3	/		V_{GS}=18V, I_D=75A, T_J=175℃	
g_{fs}	Transconductance	/	51.4	/	S	V_{DS}=20V, I_{DS}=75A	Fig. 7
		/	46.5	/		V_{DS}=20V, I_{DS}=75A, T_J=175℃	
C_{iss}	Input Capacitance	/	6046	/	pF	V_{GS}=0V V_{DS}=1000V f=100kHz	Fig. 17,18
C_{oss}	Output Capacitance	/	217	/			
C_{rss}	Reverse Transfer Capacitance	/	24	/			
E_{oss}	C_{oss} Stored Energy	/	154	/	μJ	V_{AC}=25mV	Fig. 16
E_{ON}	Turn-On Switching Energy	/	2.1	/	mJ	V_{DS}=800V, V_{GS}=-4V/18V	
E_{OFF}	Turn-Off Switching Energy	/	1.3	/		I_D=40A, $R_{G(ext)}$=2.5Ω, L=100μH	
$t_{d(on)}$	Turn-On Delay Time	/	50	/	ns	V_{DS}=800V, V_{GS}=-4V/18V, I_D=40A $R_{G(ext)}$=2.5Ω, R_L=20Ω	
t_r	Rise Time	/	28	/			
$t_{d(off)}$	Turn-Off Delay Time	/	68	/			
t_f	Fall Time	/	25	/			
$R_{G(int)}$	Internal Gate Resistance	/	2.1	/	Ω	f=1MHz, V_{AC}=25mV	
Q_{GS}	Gate to Source Charge	/	85	/	nC	V_{DS}=800V V_{GS}=-4V/18V I_D=40A	Fig. 12
Q_{GD}	Gate to Drain Charge	/	62	/			
Q_G	Total Gate Charge	/	349	/			

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.2	/	V	V_{GS}=-4V, I_{SD}=37.5A	Fig. 8,9,10
		3.9	/		V_{GS}=-4V, I_{SD}=37.5A, T_J=175℃	
I_S	Continuous Diode Forward Current	/	120	A	T_C=25℃	
t_{rr}	Reverse Recover Time	56	/	ns	V_R=800V, I_{SD}=40A	
Q_{rr}	Reverse Recovery Charge	430	/	nC		
I_{rrm}	Peak Reverse Recovery Current	21	/	A		

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.21	/	℃/W		
$R_{\theta JA}$	Thermal Resistance from Junction to Ambient	/	40			

Typical Performance

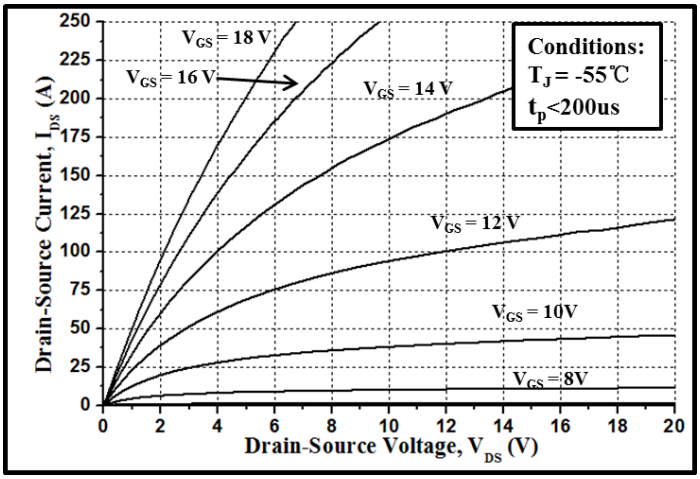


Figure 1. Output Characteristics T_J = -55℃

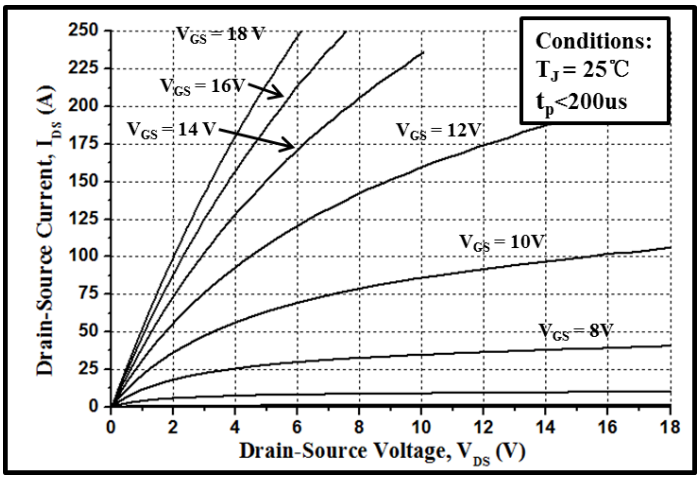


Figure 2. Output Characteristics T_J = 25℃

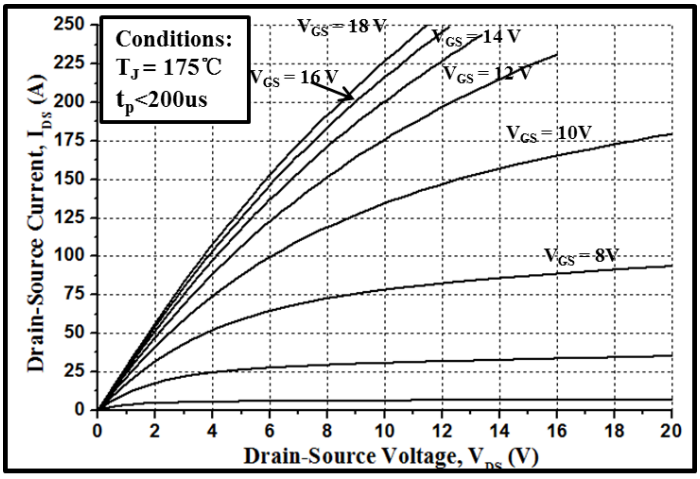


Figure 3. Output Characteristics T_J = 175℃

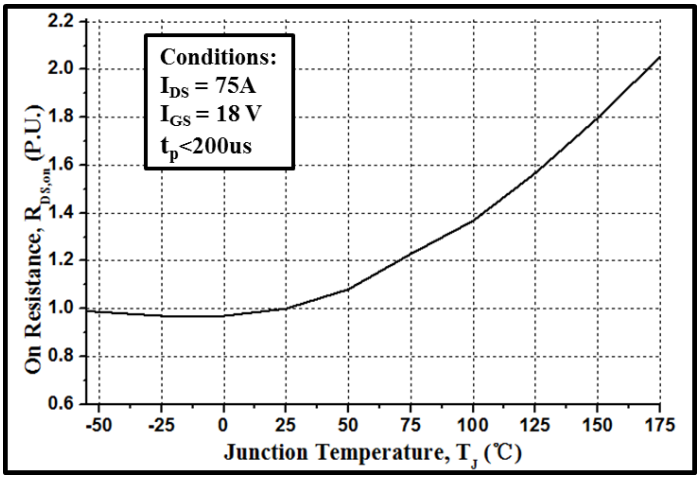


Figure 4. Normalized On-Resistance vs. Temperature

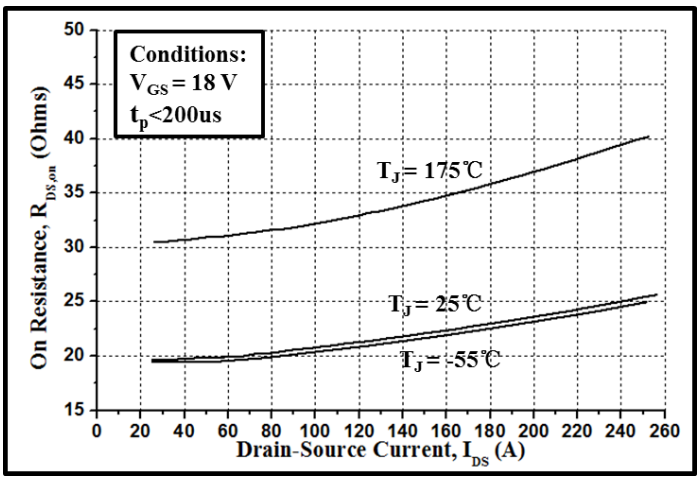


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

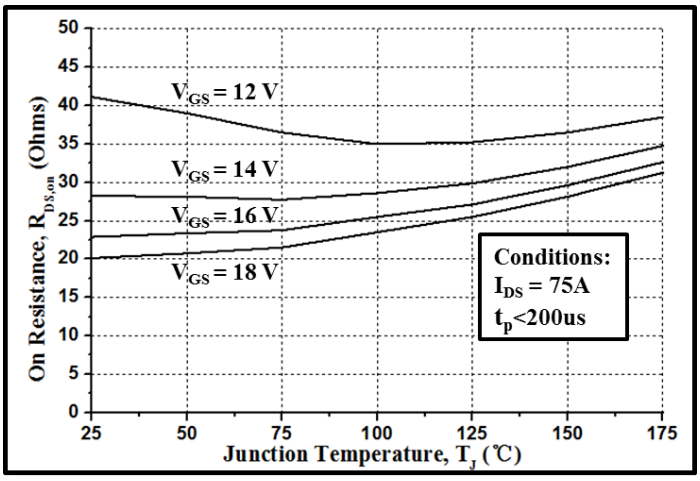


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

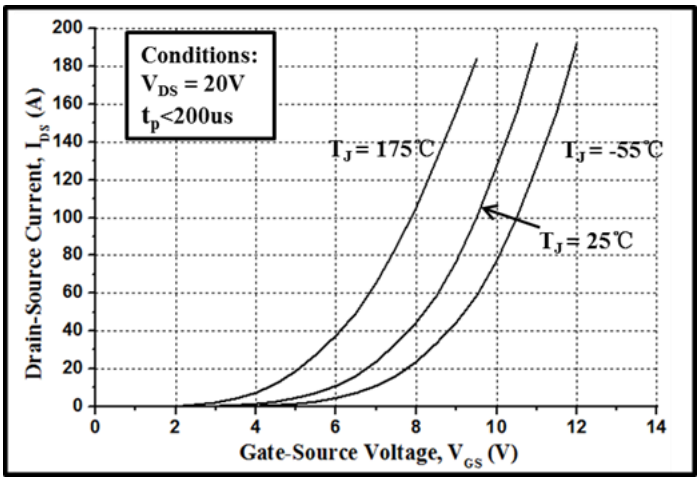


Figure 7. Transfer Characteristic for Various Junction Temperatures

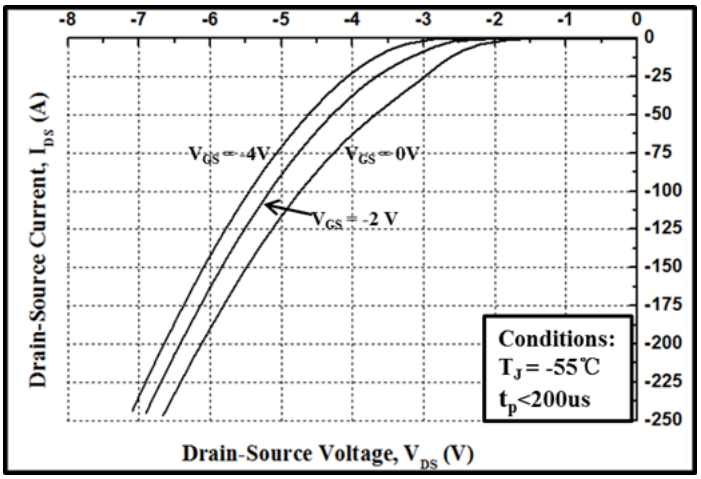


Figure 8. Body Diode Characteristic at -55℃

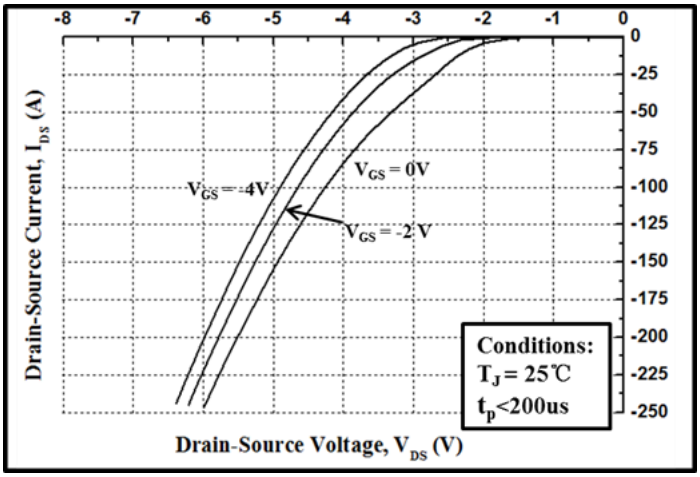


Figure 9. Body Diode Characteristic at 25℃

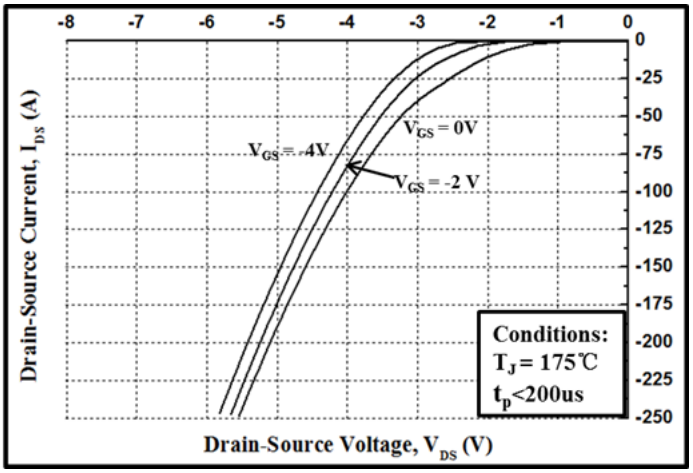


Figure 10. Body Diode Characteristic at 175℃

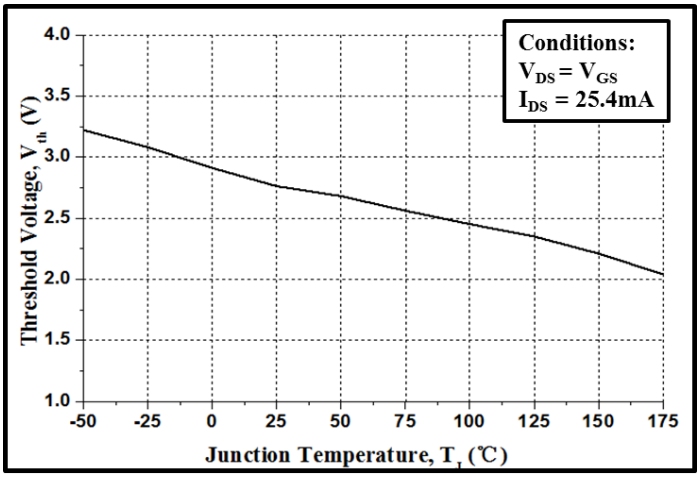


Figure 11. Threshold Voltage vs. Temperature

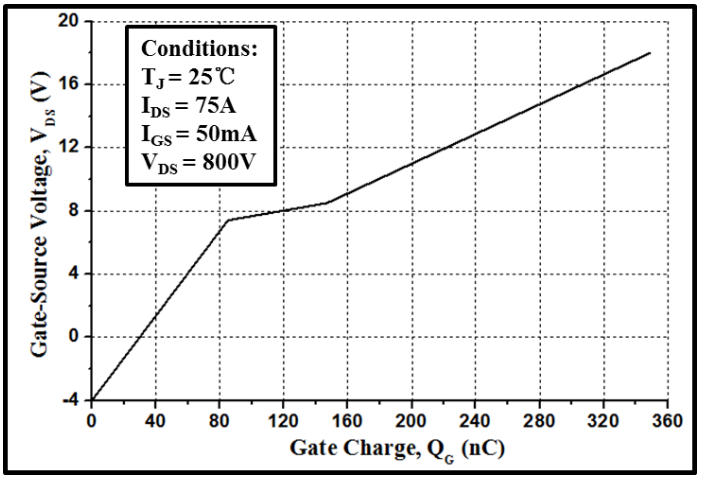


Figure 12. Gate Charge Characteristics

Typical Performance

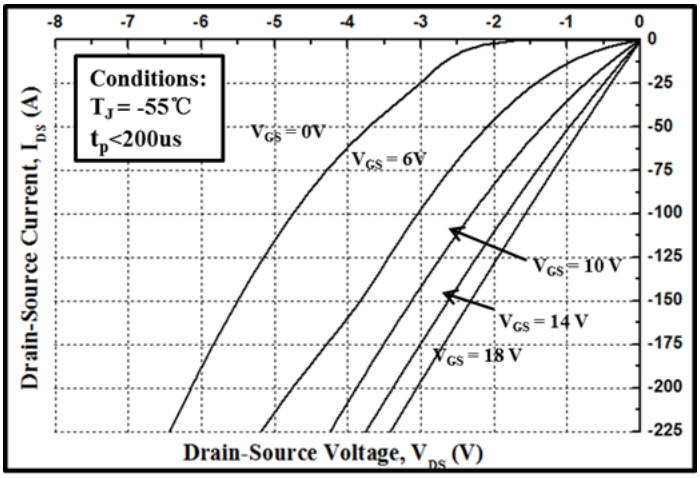


Figure 13. 3rd Quadrant Characteristic at -55℃

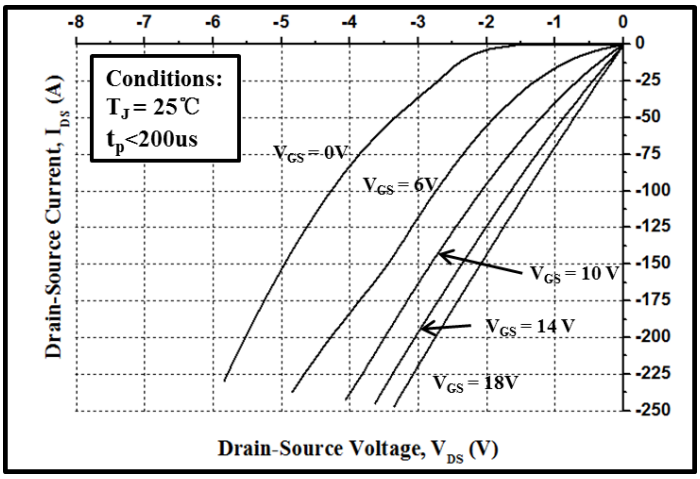


Figure 14. 3rd Quadrant Characteristic at 25℃

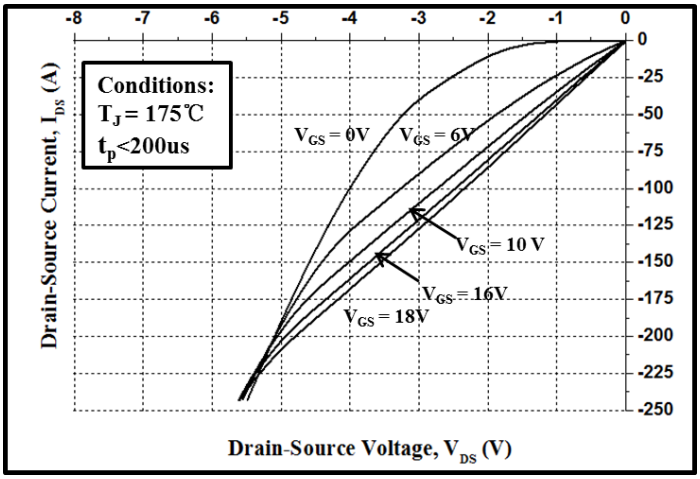


Figure 15. 3rd Quadrant Characteristic at 175℃

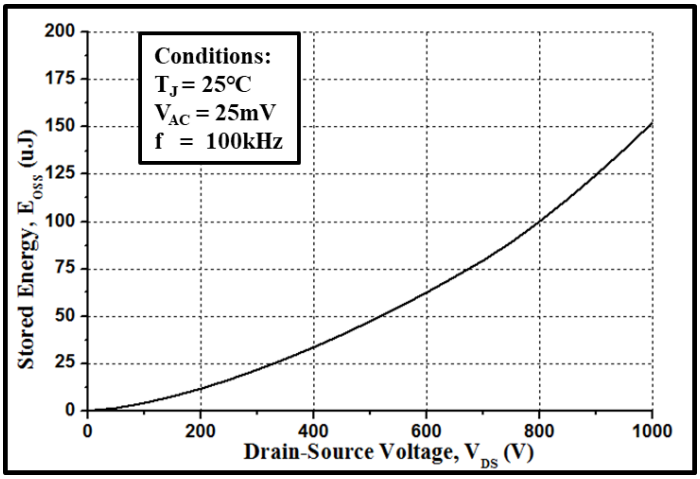


Figure16. Output Capacitor Stored Energy

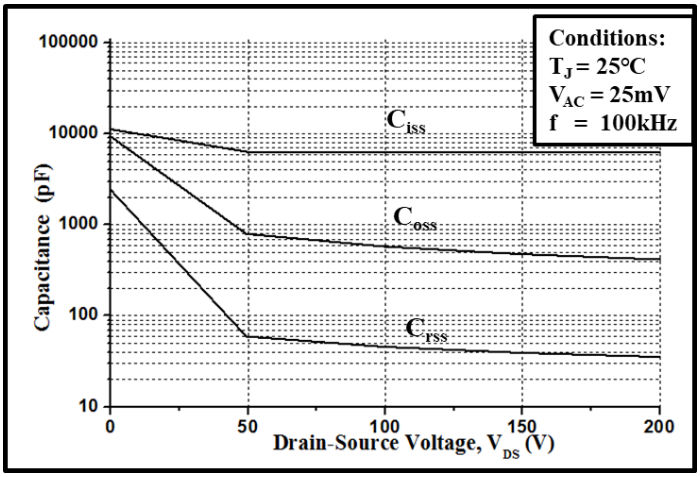


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

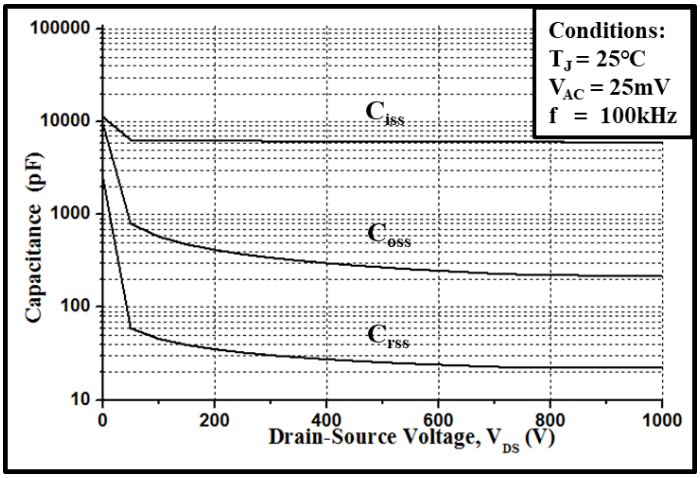


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

Typical Performance

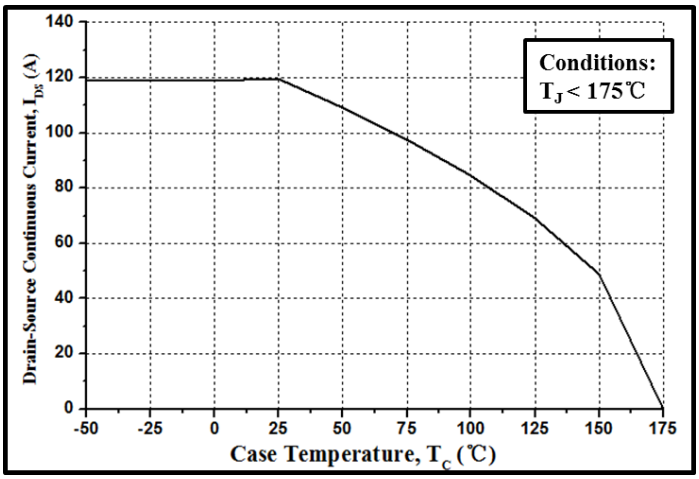


Figure 19. Continuous Drain Current Derating vs. Case Temperature

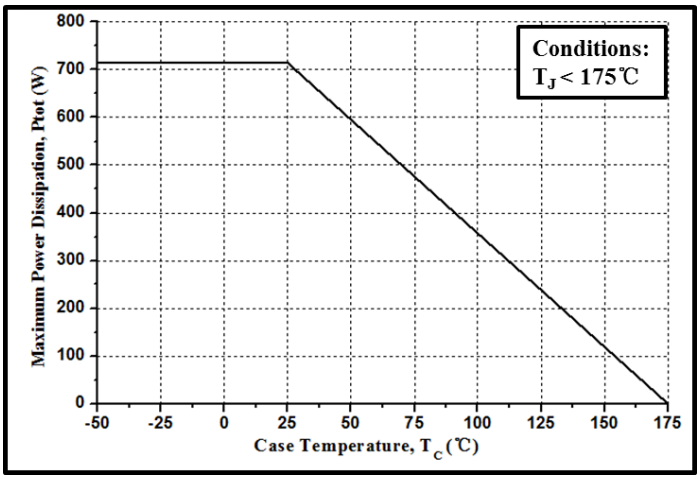
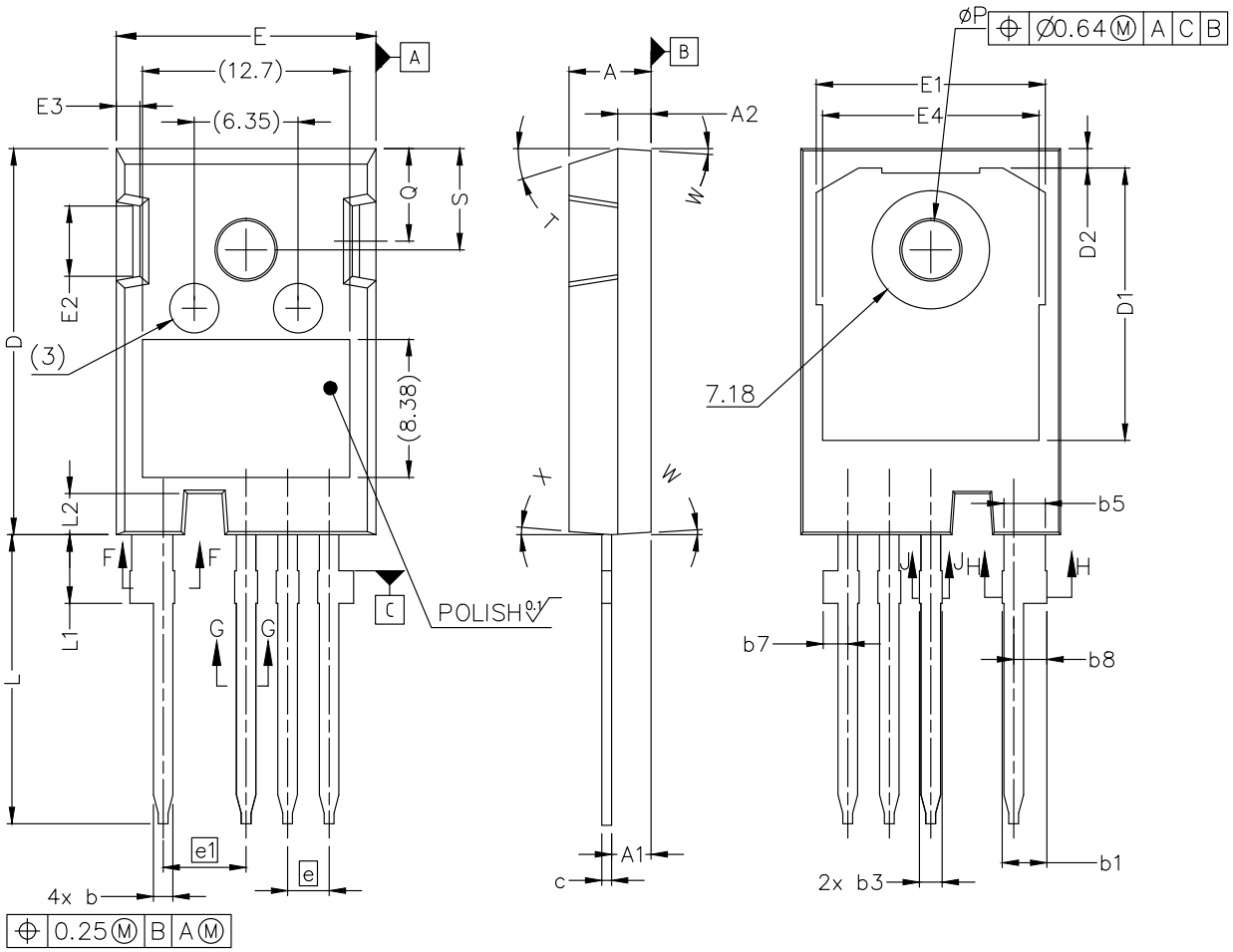
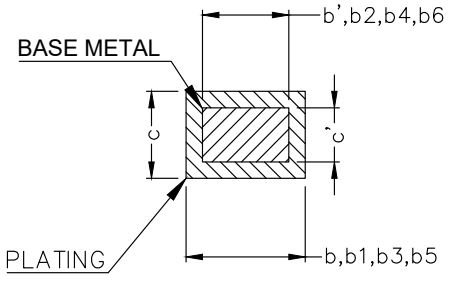


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

Package Dimensions: TO-247-4





SECTION "F-F", "G-G" , "H-H" & "J-J"
SCALE: NONE

Package Dimensions: TO-247-4

NOTE ;
1. ALL METAL SURFACES: TIN PLATED,EXCEPT AREA OF CUT .
2. DIMENSIONING & TOLERANCEING CONFIRM TO
   ASME Y14.5M-1994.
3. ALL DIMENSIONS ARE IN MILLIMETERS.
   ANGLES ARE IN DEGREES.
4. 'N' IS THE NUMBER OF TERMINAL POSITIONS .
5. DIMENSION DO NOT INCLUDE BURR OR MOLD FLASH.

SYM	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b'	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
b7	1.30	1.70
b8	1.80	2.20

c'	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N*	4	
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
øP	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5 ° REF.	
X	4° REF.	

Recommended Solder Pad Layout